

# **MOSFET**

Metal Oxide Semiconductor Field Effect Transistor

# CoolMOS™ P6

600V CoolMOS™ P6 Power Transistor IPW60R041P6

# **Data Sheet**

Rev. 2.0 Final



#### IPW60R041P6

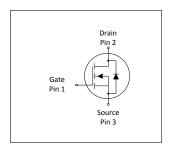
# 1 Description

CoolMOS™ is a revolutionary technology for high voltage power MOSFETs, designed according to the superjunction (SJ) principle and pioneered by Infineon Technologies. CoolMOS™ P6 series combines the experience of the leading SJ MOSFET supplier with high class innovation. The offered devices provide all benefits of a fast switching SJ MOSFET while not sacrificing ease of use. Extremely low switching and conduction losses make switching applications even more efficient, more compact, lighter and cooler.

# TO-247

#### **Features**

- Increased MOSFET dv/dt ruggedness
- Extremely low losses due to very low FOM Rdson\*Qg and Eoss
- Very high commutation ruggedness
- Easy to use/drive
- Pb-free plating, Halogen free mold compound
- Qualified for industrial grade applications according to JEDEC (J-STD20 and JESD22)



#### **Applications**

PFC stages, hard switching PWM stages and resonant switching stages for e.g. PC Silverbox, Adapter, LCD & PDP TV, Lighting, Server, Telecom and UPS.





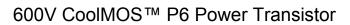
Please note: For MOSFET paralleling the use of ferrite beads on the gate or separate totem poles is generally recommended.



### **Table 1** Key Performance Parameters

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Parameter	Value	Unit						
V <sub>DS</sub> @ T <sub>j,max</sub>	650	V						
R <sub>DS(on),max</sub>	41	mΩ						
Q <sub>g.typ</sub>	170	nC						
$I_{D,pulse}$	267	А						
E <sub>oss</sub> @400V	20.5	μJ						
Body diode di/dt	300	A/µs						

Type / Ordering Code	Package	Marking	Related Links
IPW60R041P6	PG-TO 247	6R041P6	see Appendix A





# IPW60R041P6

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**2** Maximum ratings at  $T_j = 25$ °C, unless otherwise specified

Table 2 **Maximum ratings** 

Barranatan	Values				1114	
Parameter	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Continuous drain current 1)	I <sub>D</sub>	-	-	77.5 49.0	А	T <sub>C</sub> =25°C T <sub>C</sub> =100°C
Pulsed drain current 2)	I <sub>D,pulse</sub>	-	-	267	Α	T <sub>C</sub> =25°C
Avalanche energy, single pulse	<b>E</b> <sub>AS</sub>	-	-	1954	mJ	$I_D$ =13.4A; $V_{DD}$ =50V; see table 10
Avalanche energy, repetitive	<b>E</b> AR	-	-	2.96	mJ	I <sub>D</sub> =13.4A; V <sub>DD</sub> =50V; see table 10
Avalanche current, repetitive	I <sub>AR</sub>	-	-	13.4	Α	-
MOSFET dv/dt ruggedness	dv/dt	-	-	100	V/ns	V <sub>DS</sub> =0400V
Gate source voltage (static)	V <sub>GS</sub>	-20	-	20	V	static;
Gate source voltage (dynamic)	V <sub>GS</sub>	-30	-	30	V	AC (f>1 Hz)
Power dissipation (Non FullPAK) TO-247	P <sub>tot</sub>	-	-	481	W	T <sub>C</sub> =25°C
Storage temperature	T <sub>stg</sub>	-55	-	150	°C	-
Operating junction temperature	T <sub>j</sub>	-55	-	150	°C	-
Mounting torque (Non FullPAK) TO-247	-	-	-	60	Ncm	M3 and M3.5 screws
Continuous diode forward current	Is	-	-	67.2	Α	<i>T</i> <sub>C</sub> =25°C
Diode pulse current <sup>2)</sup>	I <sub>S,pulse</sub>	-	-	267	Α	T <sub>C</sub> =25°C
Reverse diode dv/dt <sup>3)</sup>	dv/dt	-	-	15	V/ns	$V_{\rm DS}$ =0400V, $I_{\rm SD}$ <= $I_{\rm S}$ , $T_{\rm j}$ =25°C see table 8
Maximum diode commutation speed	di <sub>f</sub> /dt	-	-	300	A/μs	$V_{DS}$ =0400V, $I_{SD}$ <= $I_{S}$ , $T_{j}$ =25°C see table 8

 $<sup>^{1)}</sup>$  Limited by  $T_{j\,max}.$  Maximum duty cycle D=0.75  $^{2)}$  Pulse width  $t_p$  limited by  $T_{j,max}$   $^{3)}$  Identical low side and high side switch with identical  $\textit{R}_{\text{G}}$ 



# 3 Thermal characteristics

Table 3 Thermal characteristics (Non FullPAK) TO-247

Paramatan	Ob. a.l	Values			11 14	Nada / Tand On a didina	
Parameter	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition	
Thermal resistance, junction - case	R <sub>thJC</sub>	-	-	0.26	°C/W	-	
Thermal resistance, junction - ambient	R <sub>thJA</sub>	-	-	62	°C/W	leaded	
Soldering temperature, wavesoldering only allowed at leads	T <sub>sold</sub>	-	-	260	°C	1.6mm (0.063 in.) from case for 10s	



# **4 Electrical characteristics** at $T_j$ =25°C, unless otherwise specified

Table 4 **Static characteristics** 

Parameter	Correction I		Values			N
	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Drain-source breakdown voltage	V <sub>(BR)DSS</sub>	600	-	-	V	$V_{GS}$ =0V, $I_{D}$ =1mA
Gate threshold voltage	$V_{(GS)th}$	3.5	4.0	4.5	V	$V_{\rm DS}=V_{\rm GS},\ I_{\rm D}=2.96{\rm mA}$
Zero gate voltage drain current	I <sub>DSS</sub>	-	- 10	5	μΑ	V <sub>DS</sub> =600, V <sub>GS</sub> =0V, T <sub>j</sub> =25°C V <sub>DS</sub> =600, V <sub>GS</sub> =0V, T <sub>j</sub> =150°C
Gate-source leakage current	I <sub>GSS</sub>	-	-	100	nA	V <sub>GS</sub> =20V, V <sub>DS</sub> =0V
Drain-source on-state resistance	R <sub>DS(on)</sub>	-	0.037 0.096	0.041	Ω	V <sub>GS</sub> =10V, I <sub>D</sub> =35.5A, T <sub>j</sub> =25°C V <sub>GS</sub> =10V, I <sub>D</sub> =35.5A, T <sub>j</sub> =150°C
Gate resistance	<b>R</b> <sub>G</sub>	-	1	-	Ω	f=1MHz, open drain

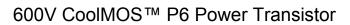
Table 5 **Dynamic characteristics** 

Damamatan	Or made at	Values			11!4	Nata / Tank Oam distant
Parameter	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Input capacitance	Ciss	-	8180	-	pF	V <sub>GS</sub> =0V, V <sub>DS</sub> =100V, f=1MHz
Output capacitance	Coss	-	310	-	pF	V <sub>GS</sub> =0V, V <sub>DS</sub> =100V, f=1MHz
Effective output capacitance, energy related 1)	C <sub>o(er)</sub>	-	260	-	pF	V <sub>GS</sub> =0V, V <sub>DS</sub> =0400V
Effective output capacitance, time related <sup>2)</sup>	C <sub>o(tr)</sub>	-	1200	-	pF	$I_D$ =constant, $V_{GS}$ =0V, $V_{DS}$ =0400V
Turn-on delay time	$t_{ m d(on)}$	-	29	-	ns	$V_{\rm DD}$ =400V, $V_{\rm GS}$ =13V, $I_{\rm D}$ =44.4A, $R_{\rm G}$ =1.7 $\Omega$ ; see table 9
Rise time	$t_{r}$	-	27	-	ns	$V_{\rm DD}$ =400V, $V_{\rm GS}$ =13V, $I_{\rm D}$ =44.4A, $R_{\rm G}$ =1.7 $\Omega$ ; see table 9
Turn-off delay time	$t_{ m d(off)}$	-	90	-	ns	$V_{\rm DD}$ =400V, $V_{\rm GS}$ =13V, $I_{\rm D}$ =44.4A, $R_{\rm G}$ =1.7 $\Omega$ ; see table 9
Fall time	t <sub>f</sub>	-	5	-	ns	$V_{\rm DD}$ =400V, $V_{\rm GS}$ =13 V, $I_{\rm D}$ =44.4A, $R_{\rm G}$ =1.7 $\Omega$ ; see table 9

Table 6 Gate charge characteristics

Parameter	Cumbal	Values			11:4	Nata / Taat Candition
	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Gate to source charge	Q <sub>gs</sub>	-	50	-	nC	$V_{DD}$ =400V, $I_{D}$ =44.4A, $V_{GS}$ =0 to 10V
Gate to drain charge	$Q_{ m gd}$	-	59	-	nC	$V_{DD}$ =400V, $I_{D}$ =44.4A, $V_{GS}$ =0 to 10V
Gate charge total	<b>Q</b> g	-	170	-	nC	$V_{DD}$ =400V, $I_{D}$ =44.4A, $V_{GS}$ =0 to 10V
Gate plateau voltage	V <sub>plateau</sub>	-	6.1	-	V	$V_{DD}$ =400V, $I_{D}$ =44.4A, $V_{GS}$ =0 to 10V

 $<sup>^{1)}</sup>$   $C_{\text{o(er)}}$  is a fixed capacitance that gives the same stored energy as  $C_{\text{oss}}$  while  $V_{\text{DS}}$  is rising from 0 to 400V  $^{2)}$   $C_{\text{o(tr)}}$  is a fixed capacitance that gives the same charging time as  $C_{\text{oss}}$  while  $V_{\text{DS}}$  is rising from 0 to 400V





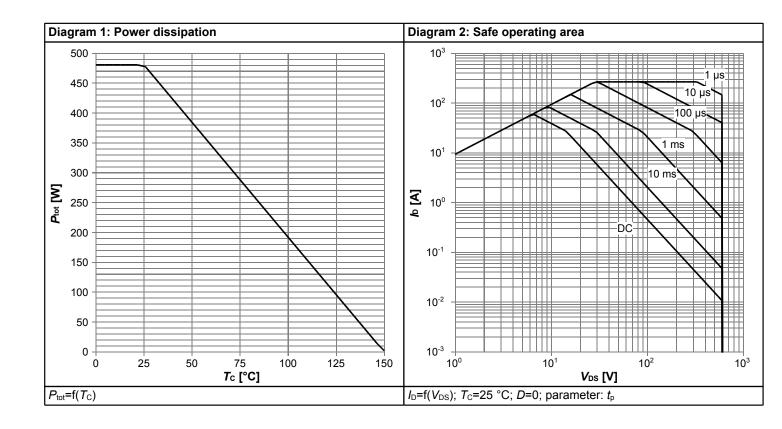
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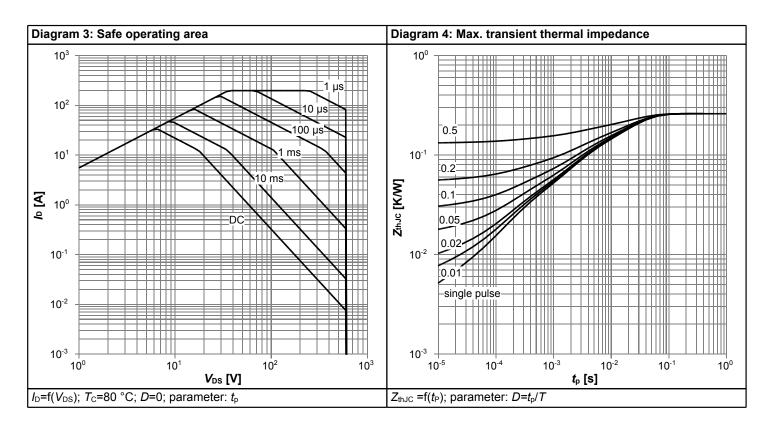
# Table 7 Reverse diode characteristics

Doromotor	Cumbal	Values			Unit	Note / Test Condition	
Parameter	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition	
Diode forward voltage	V <sub>SD</sub>	-	0.9	-	V	V <sub>GS</sub> =0V, I <sub>F</sub> =44.4A, T <sub>j</sub> =25°C	
Reverse recovery time	t <sub>rr</sub>	-	630	-	ns	$V_R$ =400V, $I_F$ =44.4A, $di_F/dt$ =100A/ $\mu$ s; see table 8	
Reverse recovery charge	Q <sub>rr</sub>	-	19	-	μC	$V_R$ =400V, $I_F$ =44.4A, $di_F/dt$ =100A/ $\mu$ s; see table 8	
Peak reverse recovery current	I <sub>rrm</sub>	-	56	-	А	$V_R$ =400V, $I_F$ =44.4A, $di_F/dt$ =100A/ $\mu$ s; see table 8	

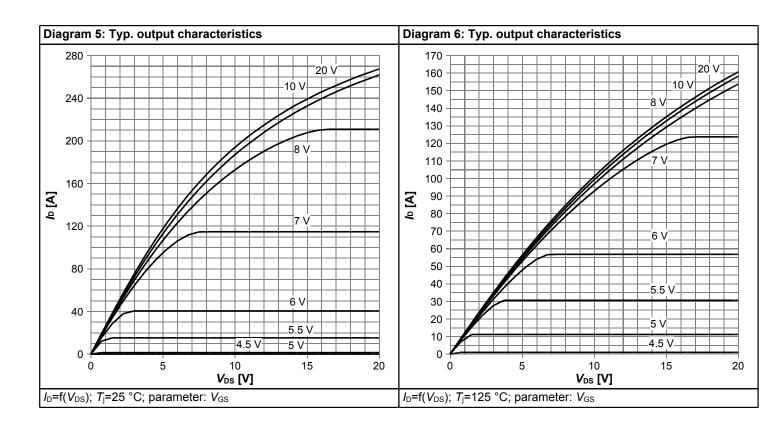


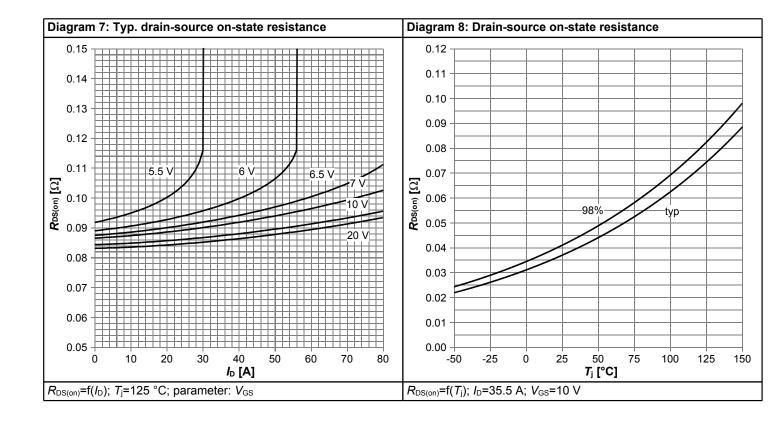
# 5 Electrical characteristics diagrams



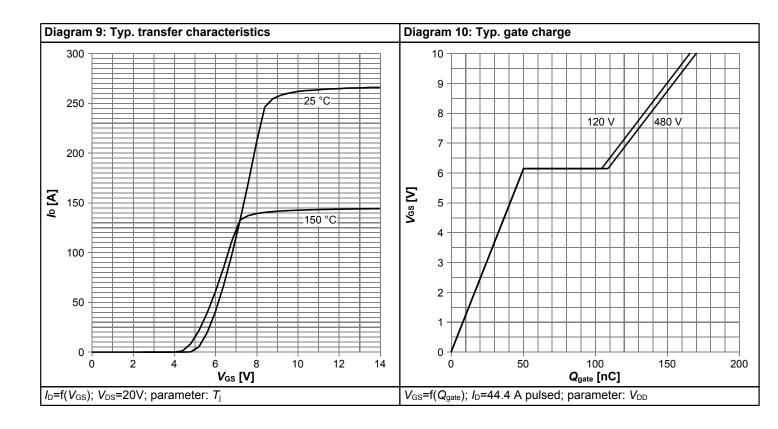


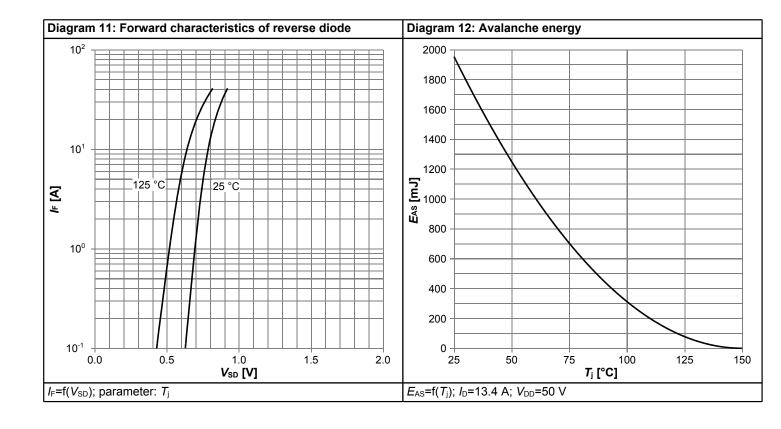




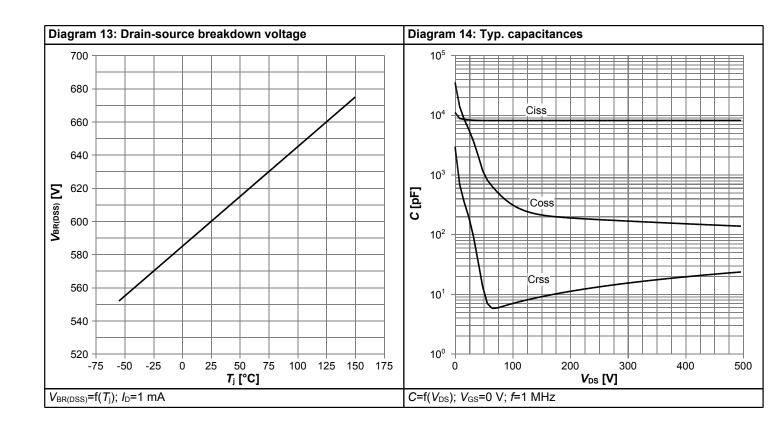


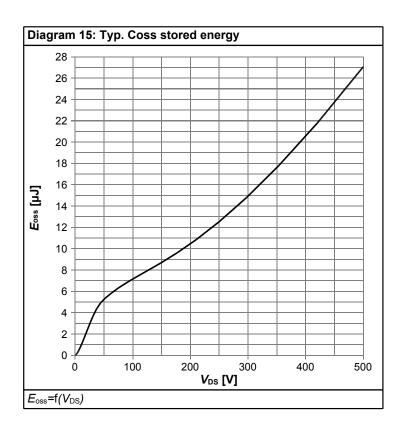














#### 6 Test Circuits

Table 8 Diode characteristics

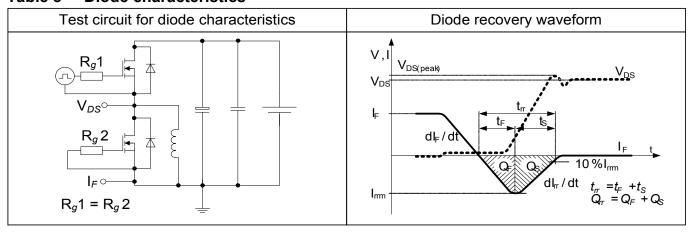


Table 9 Switching times

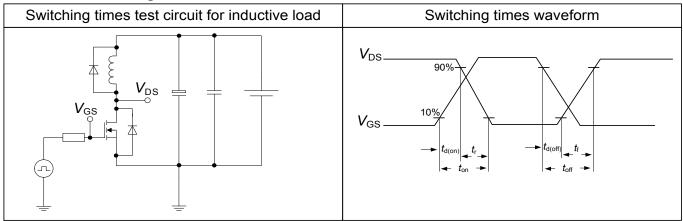
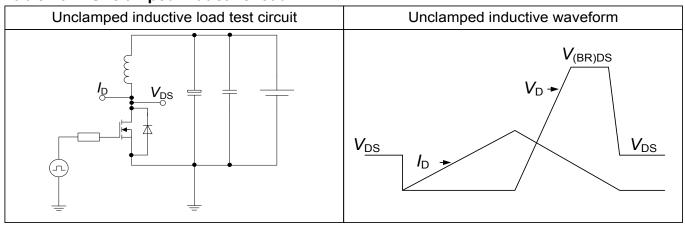


Table 10 Unclamped inductive load





# 7 Package Outlines

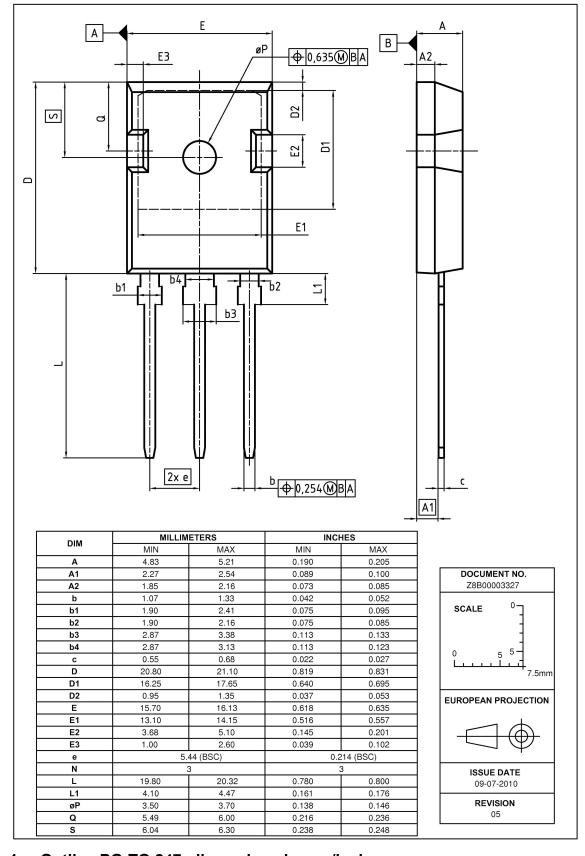


Figure 1 Outline PG-TO 247, dimensions in mm/inches



# 8 Appendix A

#### Table 11 Related Links

- IFX CoolMOS<sup>™</sup> P6 Webpage: www.infineon.com
- IFX CoolMOS<sup>™</sup> P6 application note: www.infineon.com
- IFX CoolMOS<sup>™</sup> P6 simulation model: www.infineon.com
- IFX Design tools: www.infineon.com



#### 600V CoolMOS™ P6 Power Transistor

IPW60R041P6

#### **Revision History**

IPW60R041P6

Revision: 2014-03-07, Rev. 2.0

Previous Revision

r revious revision							
Revision	Date	Subjects (major changes since last revision)					
2.0	2014-03-07	Release of final version					

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